

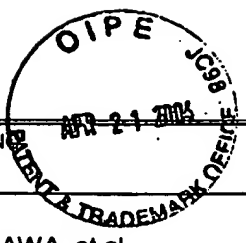
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214320US2		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Fuminobu OGAWA, et al.			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
MR	AO	6-233289	8/19/94	Japan (with English Abstract)			X
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner /Melur Ramakrishnaiah/					Date Considered 06/01/2006		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214320US2		SERIAL NO. 09/963,474	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Fuminobu OGAWA, et al.			
				FILING DATE September 27, 2001		GROUP 2622	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
MR	AO	2001-333397	11/30/2001	JAPAN (with English Abstract)			X
	AP	2001-186488	07/06/2001	JAPAN (with English Abstract)			X
	AQ	4-344787	12/01/92	JAPAN (with English Abstract)			X
	AR	8-294101	11/05/96	JAPAN (with English Abstract)			X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Melur Ramakrishnaiah/					Date Considered 06/01/2006		
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(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
214320US2SERIAL NO.
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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Fuminobu OGAWA, et al.FILING DATE
September 27, 2001GROUP
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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
MR	AO	2000-31666	06/05/2000	KOREA (with English translation)		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
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☐ Additional References sheet(s) attached

Examiner /Melur Ramakrishnaiah/

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